



Making Use of a Decade of Widely Varying Historical Data

SARP project "Full Life-cycle Defect Management"

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Problem we are addressing

- We are in the second year of our initiative and studying
 - Parameters that affect the results of inspection
 - The relation between V&V effectiveness in early lifecycle (e.g. inspection) and late (testing)
- We are using this information to provide feedback and decision support to NASA projects, on questions such as:
 - Can I get guidance on how to plan my inspections based on results from projects like my own?
 - Based on my inspection results, what are the implications for the effort required to be spent on other non-optional activities, like system testing?







Unifying different defect classifications

- **Motivation:** Valuable defect data has been collected over the years across many Centers and projects
- **Issue:** Different defect classifications used in historic and contemporary data sets, as well as across Centers;
- **Action**: Definition of a unified defect classification schema and mapping of existing data sets into this unified schema
- Benefits:
 - Leverages data required by NPR 7150.2 for analysis and feedback to teams
 - Enables monitoring and validation of existing guidelines
 - Unified classification schema is applicable to inspections and testing

existing data sets (historic and contemporary)

actions

unified data set for contemporary project feedback



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Map historical data to new categorization if possible; partition remaining historical categories and refine new schema if needed

ODC-based new schema

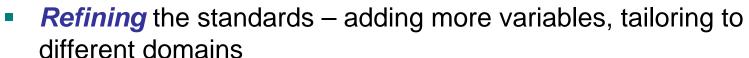




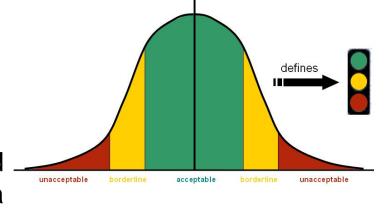
Updating existing inspection standards

NASA guidelines for effective inspections formulated in early 1990's

- Number of participants
- Page rate
- Meeting length
- Validating these standards based on a wider set of more recent data



- New standards built into
 - inspection support tool
 - inspection training
- Refined standards will increase *effectiveness* of inspections in terms of effort expended and defects found



optimum







Comparing test and inspection data

Research Questions:

What defects types are typically removed by **inspections** vs. testing?

What project characteristics (size, language, software domain, new development/enhancements) influence the types of defects

found?

What percent of logic errors can be expected to be removed by inspections?



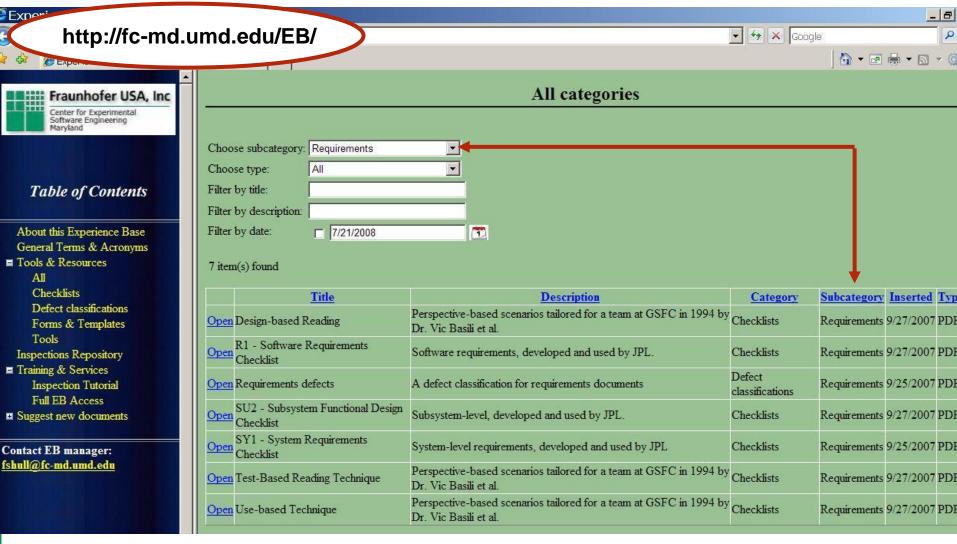


Inspections Vs. Testing Defects By Type





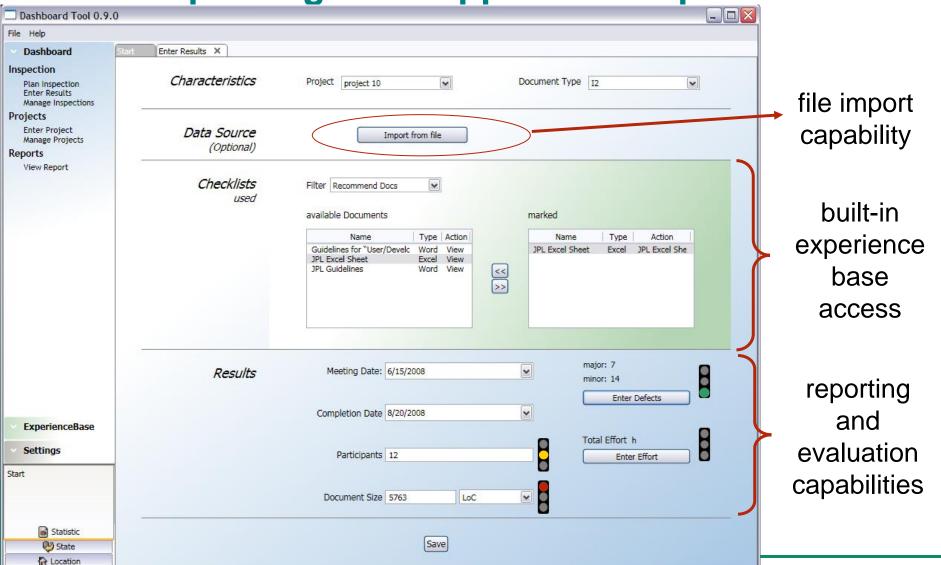
Providing an inspection experience base







Improving tool support for inspections







Accomplishments so far

- 2529 unified inspection records in database
 - more data sets are welcome
- Initial tool that supports inspection planning and reporting
 - (test) users are welcome to try the tool
- Tool can accept data from JPL forms as well as various databases
 - possibility of later integration into NASA's eRoom
- Central inspection experience base available
 - http://fc-md.umd.edu/EB
- Accepted papers at ESEM and IEEE Software
 - additional publications are currently under review or planned



More details are provided as part of our technical presentation





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Inspection Experience Base on-line at: http://fc-md.umd.edu/EB